



US006680214B1

(12) **United States Patent**  
**Tavkhelidze et al.**

(10) **Patent No.:** **US 6,680,214 B1**  
(45) **Date of Patent:** **\*Jan. 20, 2004**

- (54) **ARTIFICIAL BAND GAP** 5,023,671 A 6/1991 DiVincenzo et al.  
5,119,151 A 6/1992 Onda
- (75) Inventors: **Ayto Tavkhelidze**, Tbilisi (GE);  
**Jonathan Sidney Edelson**, Somerville,  
MA (US); **Isaiah Watas Cox**, London  
(GB); **Stuart Harbron**, Berkhamsted  
(GB) 5,229,320 A 7/1993 Ugajin  
5,233,205 A 8/1993 Usagawa et al.  
5,247,223 A 9/1993 Mori et al.  
5,332,952 A 7/1994 Ugajin et al.  
5,371,388 A 12/1994 Oda  
5,432,362 A 7/1995 Lippens et al.  
(73) Assignee: **Borealis Technical Limited** (GI) 5,521,735 A 5/1996 Shimizu et al.  
5,579,232 A 11/1996 Tong et al.  
(\* ) Notice: Subject to any disclaimer, the term of this  
patent is extended or adjusted under 35  
U.S.C. 154(b) by 526 days. 5,654,557 A 8/1997 Taneya et al.  
5,719,407 A 2/1998 Ugajin  
5,722,242 A 3/1998 Edelson  
5,772,905 A 6/1998 Chou  
6,117,344 A 9/2000 Cox et al.  
6,281,514 B1 8/2001 Tavkhelidze
- This patent is subject to a terminal disclaimer.

- (21) Appl. No.: **09/634,615**  
(22) Filed: **Aug. 5, 2000**

**OTHER PUBLICATIONS**

Chou et al., Imprint Lithography with 25 Nanometer Resolution, SCIENCE, Apr. 5, 1996, pp85-87, vol 272.

**Related U.S. Application Data**

- (63) Continuation-in-part of application No. 09/093,652, filed on Jun. 8, 1998, now abandoned.  
(60) Provisional application No. 60/149,805, filed on Aug. 18, 1999.  
(51) **Int. Cl.<sup>7</sup>** ..... **G25F 3/02**; H01L 21/00  
(52) **U.S. Cl.** ..... **438/20**; 216/40; 216/54;  
216/66; 216/67; 430/199; 430/296; 430/302;  
430/310  
(58) **Field of Search** ..... 216/11, 40, 54,  
216/66, 67; 430/199, 296, 302, 310; 438/20,  
689, 725, 463, 464; 250/493.1; 257/10,  
11

*Primary Examiner*—Savitri Mulpuri

(57) **ABSTRACT**

A method is disclosed for the induction of a suitable band gap and electron emissive properties into a substance, in which the substrate is provided with a surface structure corresponding to the interference of electron waves. Lithographic or similar techniques are used, either directly onto a metal mounted on the substrate, or onto a mold which then is used to impress the metal. In a preferred embodiment, a trench or series of nano-sized trenches are formed in the metal.

(56) **References Cited**

**U.S. PATENT DOCUMENTS**

4,686,162 A 8/1987 Stangl et al.

**20 Claims, 7 Drawing Sheets**

